

V <sub>CES</sub>	650V
I <sub>C(100°C)</sub>	17A
V <sub>CE(sat) (Typ.)</sub>	1.6V@I <sub>C</sub> =30A
P <sub>D</sub>	61W

## Features

- 1) Low Collector Emitter Saturation Voltage
- 2) High Speed Switching
- 3) Low Switching Loss & Soft Switching
- 4) Built in Very Fast & Soft Recovery FRD (RFN Series)
- 5) Pb free Lead Plating ; RoHS Compliant

# Applications

PFC

UPS

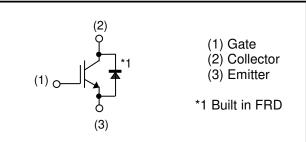
**Power Conditioner** 

IH

# Outline



## Inner Circuit



# Packaging Specifications

	Packaging	Tube
	Reel Size (mm)	-
Tupo	Tape Width (mm)	-
Туре	Basic Ordering Unit (pcs)	450
	Packing Code	C11
	Marking	RGTH60TK65D

# ●Absolute Maximum Ratings (at T<sub>C</sub> = 25°C unless otherwise specified)

		,		
Parameter		Symbol	Value	Unit
Collector - Emitter Voltage		V <sub>CES</sub>	650	V
Gate - Emitter Voltage		V <sub>GES</sub>	±30	V
Collector Current	$T_{\rm C} = 25^{\circ}{\rm C}$	Ι <sub>C</sub>	28	А
Collector Current	T <sub>C</sub> = 100°C	Ι <sub>C</sub>	17	А
Pulsed Collector Current		I <sub>CP</sub> *1	120	А
Diado Forward Current	$T_{\rm C} = 25^{\circ}{\rm C}$	١ <sub>F</sub>	28	А
Diode Forward Current	T <sub>C</sub> = 100°C	I <sub>F</sub>	16	А
Diode Pulsed Forward Current		I <sub>FP</sub> <sup>*1</sup>	120	А
Power Dissipation	$T_{\rm C} = 25^{\circ}{\rm C}$	P <sub>D</sub>	61	W
Power Dissipation	$T_{\rm C} = 100^{\circ}{\rm C}$	P <sub>D</sub>	30	W
Operating Junction Temperature		Tj	-40 to +175	°C
Storage Temperature		T <sub>stg</sub>	-55 to +175	°C
*1 Pulse width limited by T			-	

\*1 Pulse width limited by T<sub>jmax.</sub>

## Thermal Resistance

Parameter	Symbol	Values			Unit
Parameter	Symbol	Min.	Тур.	Max.	Unit
Thermal Resistance IGBT Junction - Case	$R_{\theta(j-c)}$	-	-	2.43	°C/W
Thermal Resistance Diode Junction - Case	$R_{\theta(j-c)}$	-	-	3.76	°C/W

# •IGBT Electrical Characteristics (at $T_j = 25^{\circ}C$ unless otherwise specified)

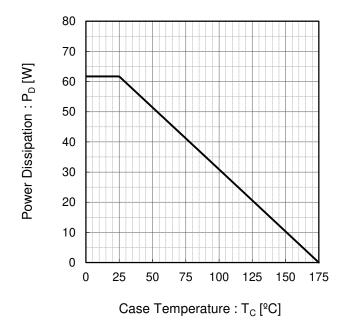
Parameter	Symbol	Conditions	Values			Unit
Farameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Collector - Emitter Breakdown Voltage	$BV_{CES}$	I <sub>C</sub> = 10μΑ, V <sub>GE</sub> = 0V	650	-	-	V
Collector Cut - off Current	I <sub>CES</sub>	$V_{CE} = 650V, V_{GE} = 0V$	-	-	10	μA
Gate - Emitter Leakage Current	I <sub>GES</sub>	$V_{GE}$ = ±30V, $V_{CE}$ = 0V	-	-	±200	nA
Gate - Emitter Threshold Voltage	$V_{GE(th)}$	$V_{CE} = 5V, I_{C} = 21.0mA$	4.5	5.5	6.5	V
Collector - Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$I_{C} = 30A, V_{GE} = 15V$ $T_{j} = 25^{\circ}C$ $T_{j} = 175^{\circ}C$	-	1.6 2.1	2.1 -	V

# •IGBT Electrical Characteristics (at $T_j = 25^{\circ}C$ unless otherwise specified)

Deremeter	Symbol	Conditions	Values			l lucit	
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	
Input Capacitance	C <sub>ies</sub>	$V_{CE} = 30V$	-	1670	-		
Output Capacitance	C <sub>oes</sub>	$V_{GE} = 0V$	-	66	-	pF	
Reverse Transfer Capacitance	C <sub>res</sub>	f = 1MHz	-	27	-		
Total Gate Charge	$Q_g$	V <sub>CE</sub> = 300V	-	58	-		
Gate - Emitter Charge	$Q_{ge}$	I <sub>C</sub> = 30A	-	15	-	nC	
Gate - Collector Charge	$Q_{gc}$	V <sub>GE</sub> = 15V	-	20	-		
Turn - on Delay Time	t <sub>d(on)</sub>	$I_{C} = 30A, V_{CC} = 400V$	-	27	-		
Rise Time	t <sub>r</sub>	$V_{GE} = 15V, R_G = 10\Omega$	-	40	-	20	
Turn - off Delay Time	$t_{d(off)}$	$T_j = 25^{\circ}C$	-	105	-	ns	
Fall Time	t <sub>f</sub>	Inductive Load	-	47	-		
Turn - on Delay Time	t <sub>d(on)</sub>	$I_{\rm C} = 30 {\rm A}, \ V_{\rm CC} = 400 {\rm V}$	-	27	-		
Rise Time	t <sub>r</sub>	$V_{GE} = 15V, R_G = 10\Omega$	-	40	-	20	
Turn - off Delay Time	$t_{d(off)}$	T <sub>j</sub> = 175°C	-	120	-	ns	
Fall Time	t <sub>f</sub>	Inductive Load	-	59	-		
		$I_{\rm C} = 120$ A, $V_{\rm CC} = 520$ V					
Reverse Bias Safe Operating Area	RBSOA	$V_{P} = 650V, V_{GE} = 15V$	FU	LL SQUA	RE	-	
		$R_{G} = 60\Omega, T_{j} = 175^{\circ}C$					

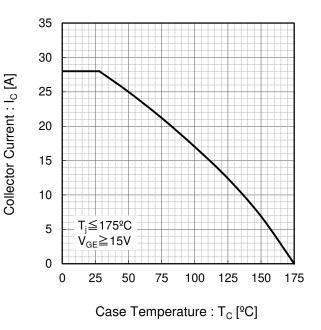
# •FRD Electrical Characteristics (at $T_j = 25^{\circ}C$ unless otherwise specified)

Devemeter	Symbol	Conditions	Values			Unit	
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	
Diode Forward Voltage	V <sub>F</sub>	$I_F = 20A$ $T_j = 25^{\circ}C$ $T_j = 175^{\circ}C$	-	1.35 1.15	1.8 -	V	
Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 20A	-	58	-	ns	
Diode Peak Reverse Recovery Current	I <sub>rr</sub>	V <sub>CC</sub> = 400V di <sub>F</sub> /dt = 200A/µs	-	6.5	-	А	
Diode Reverse Recovery Charge	Q <sub>rr</sub>	T <sub>j</sub> = 25°C	-	0.21	-	μC	
Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 20A	-	236	-	ns	
Diode Peak Reverse Recovery Current	l <sub>rr</sub>	V <sub>CC</sub> = 400V di <sub>F</sub> /dt = 200A/µs	-	10.7	-	А	
Diode Reverse Recovery Charge	Q <sub>rr</sub>	T <sub>j</sub> = 175°C	-	1.36	-	μC	



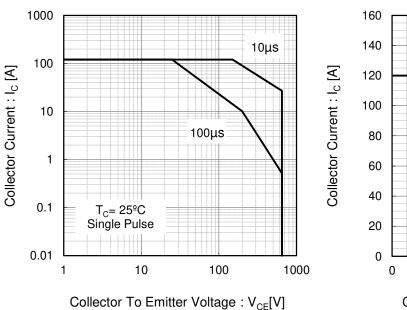
## Fig.1 Power Dissipation vs. Case Temperature

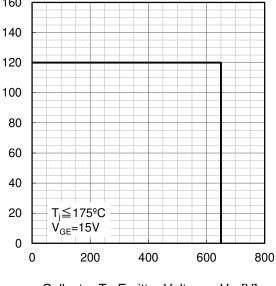
Fig.2 Collector Current vs. Case Temperature



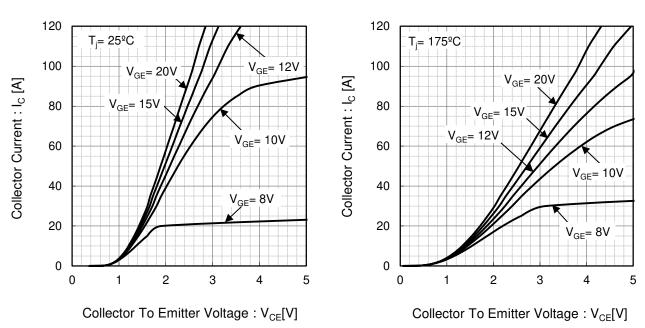
# Fig.3 Forward Bias Safe Operating Area

Fig.4 Reverse Bias Safe Operating Area





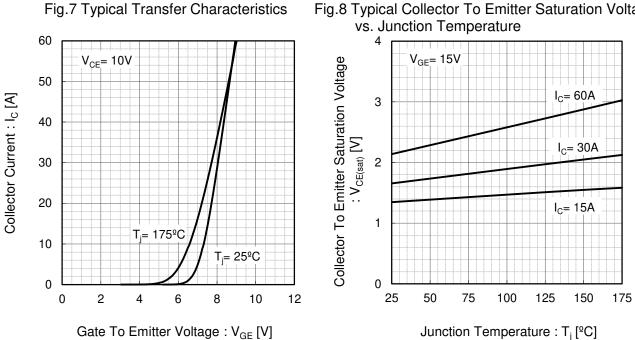
Collector To Emitter Voltage :  $V_{CE}[V]$ 



#### Fig.5 Typical Output Characteristics

Fig.8 Typical Collector To Emitter Saturation Voltage

Fig.6 Typical Output Characteristics



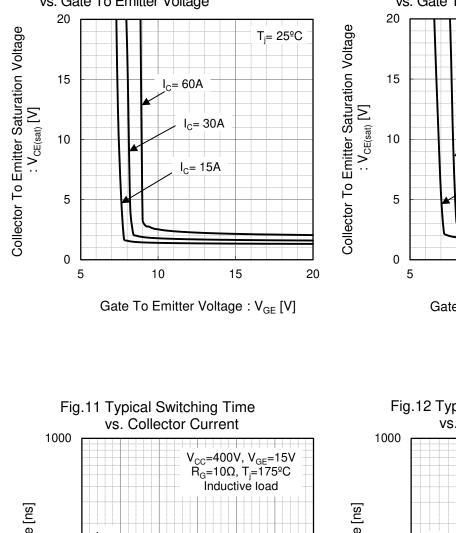


Fig.9 Typical Collector To Emitter Saturation Voltage vs. Gate To Emitter Voltage

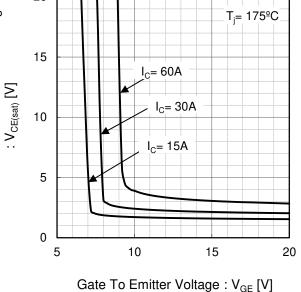
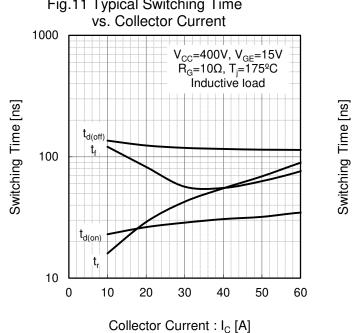
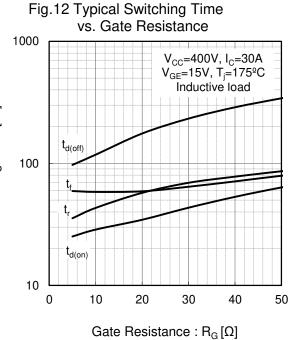
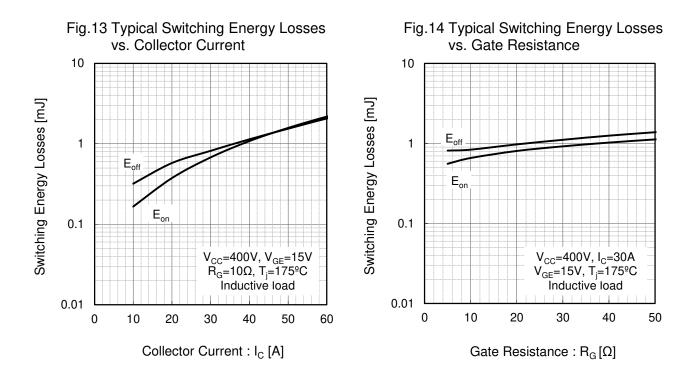


Fig.10 Typical Collector To Emitter Saturation Voltage vs. Gate To Emitter Voltage







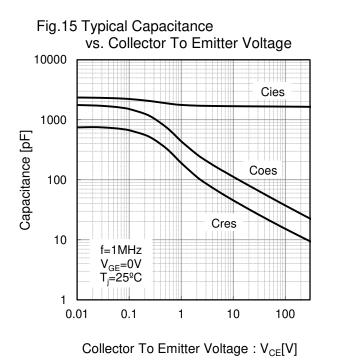
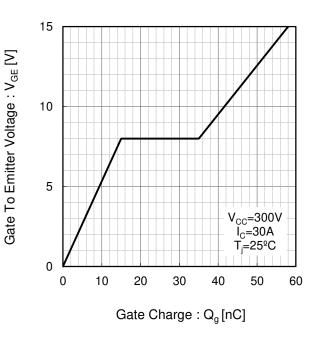
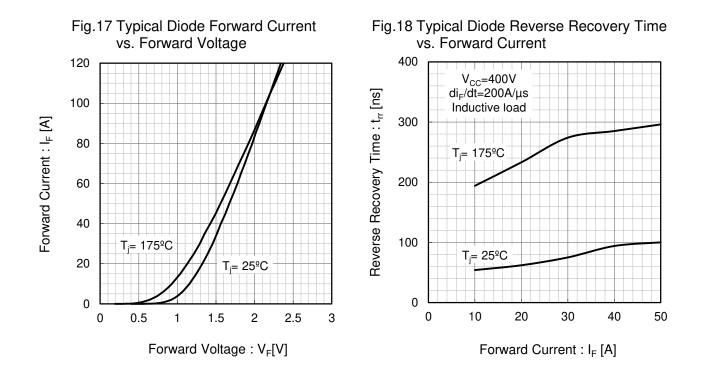


Fig.16 Typical Gate Charge





# Fig.19 Typical Diode Reverse Recovery Current vs. Forward Current

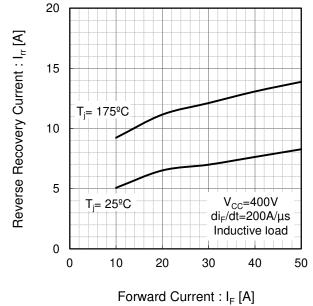
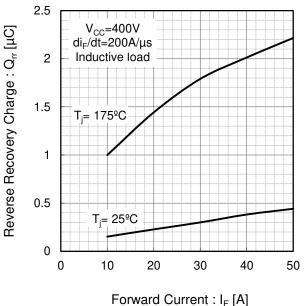


Fig.20 Typical Diode Reverse Recovery Charge vs. Forward Current



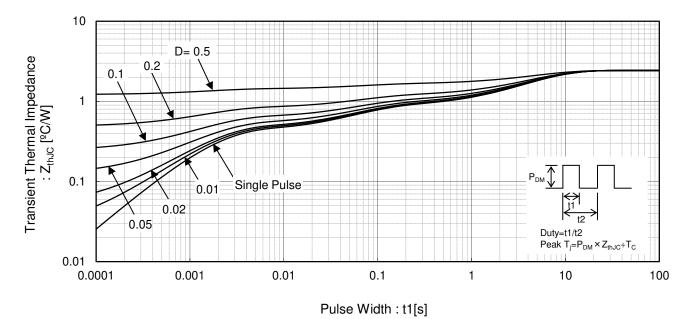
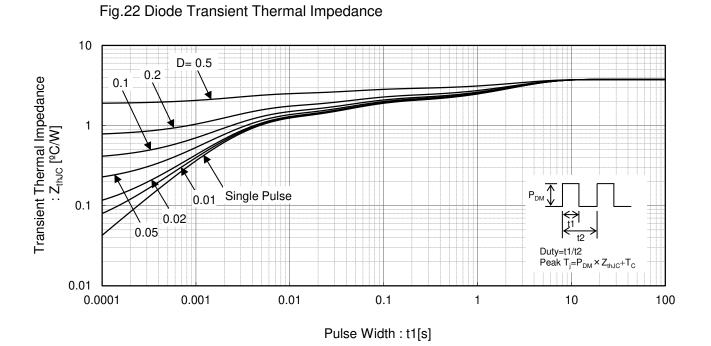


Fig.21 IGBT Transient Thermal Impedance





# ●Inductive Load Switching Circuit and Waveform

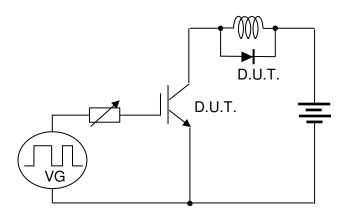


Fig.23 Inductive Load Circuit

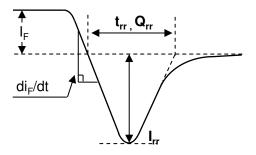
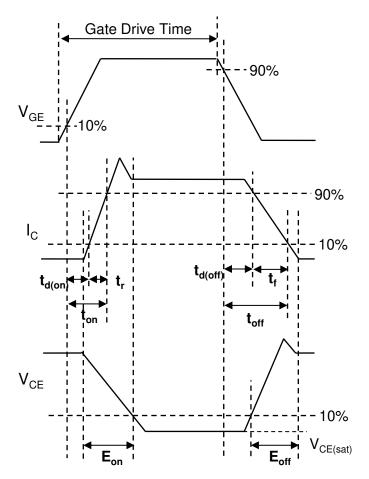
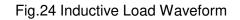


Fig.25 Diode Reverce Recovery Waveform





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